Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/828,961	LEE ET AL.
Examiner	Art Unit
Alnus H. Hsu	2665

	SEARCHED				
Class	Subclass	Date	Examiner		
370	254,328 338,401 465	71/05	byrd		
	412.1,414.1 414.2,456.1				
709	220, 223				
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INTERFERENCE SEARCHED					
Class	Subclass	Date		Examiner	
370	254,338	7/1	105	1244	
455	414,2				
709	220,224				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
·	· DATE	EXMR		
TAST	7/1/05	BHH		